

Dynamic Tensile Characterization of Foam Materials

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Polymeric Foams

Polymeric Foams

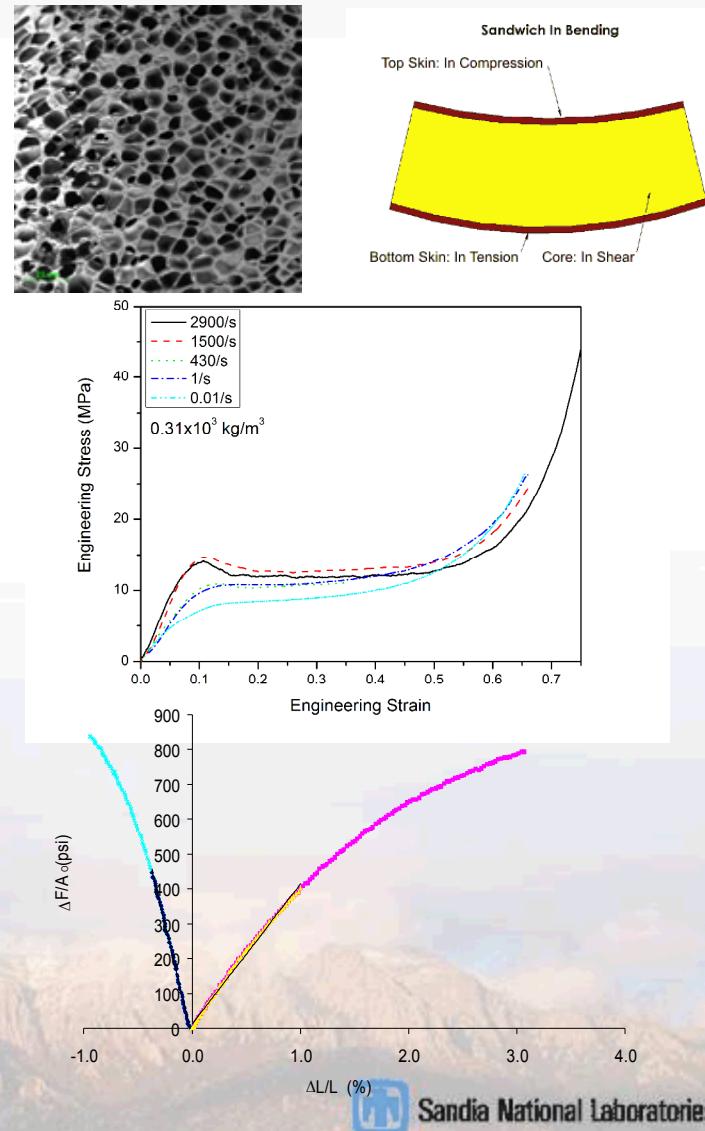
- Light weight
- Superior energy absorption capabilities
- Applications to impact events
 - Core material in sandwich structures

■ Unique mechanical response in compression and tension

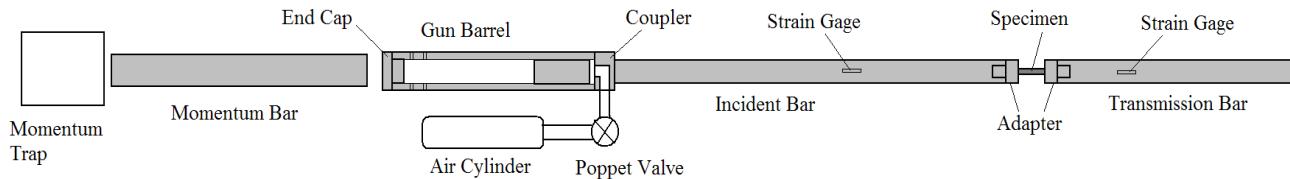
- Significant difference in stress-strain response under compression and tension
 - Foam materials may be subjected to impact tension in applications

- Bending
- Spalling
- ...

- Dynamic tensile response is desirable



High-Rate Tensile Characterization with Kolsky Tension Bar



Kolsky Tension Bar Developed at Sandia California
(presented at 2010 SEM Annual Conference)

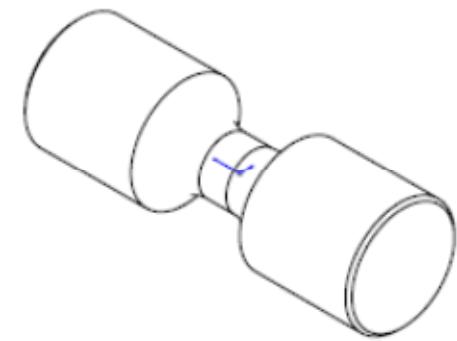
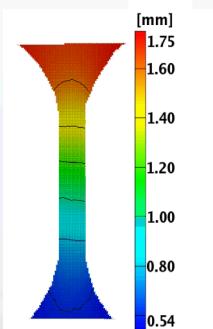
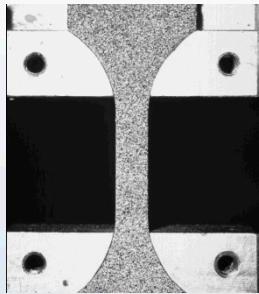
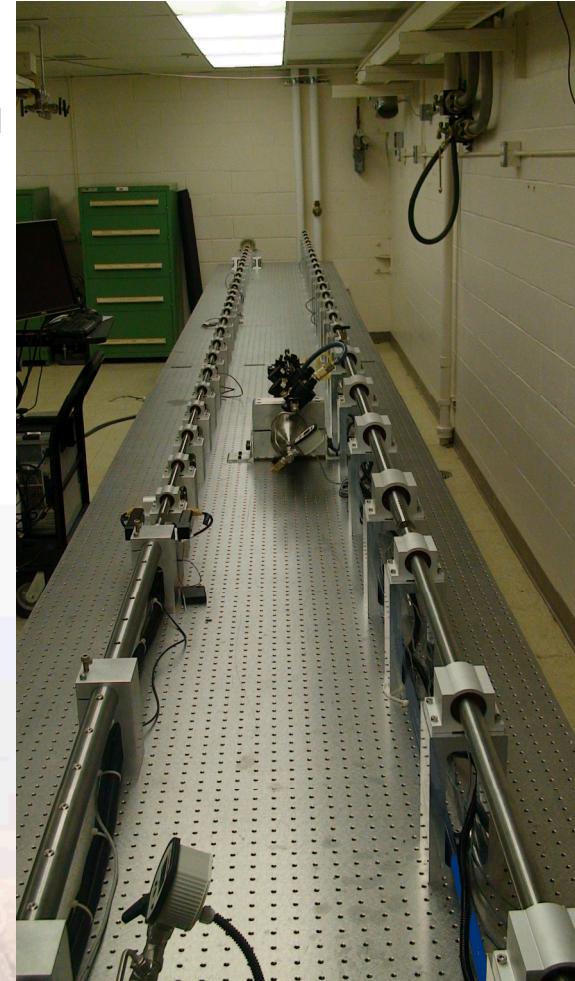


Plate Specimen

Dumbbell Cylinder Specimen

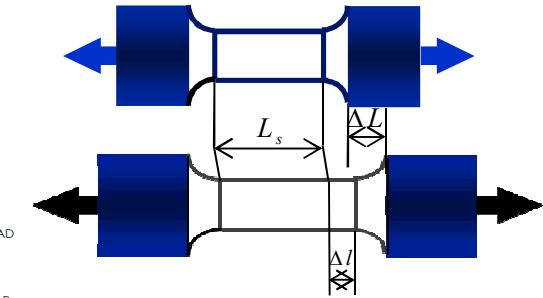
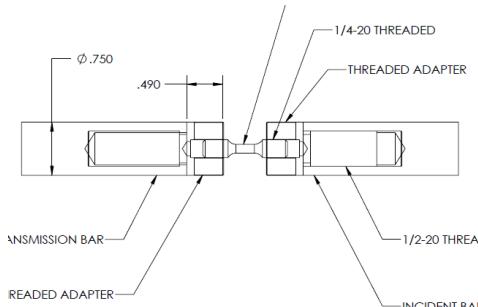


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Challenges

■ Stress measurement

- Low yield/failure strength
- Stress equilibrium
 - Short specimen gage length
 - Control of initial loading rate



■ Strain measurement

- Displacement measurement of incident bar end
 - Using incident and reflected pulses may not give precise measurement of displacement due to possible wave disturbance by adapters, ...
- Determination of gage length of dumbbell specimen

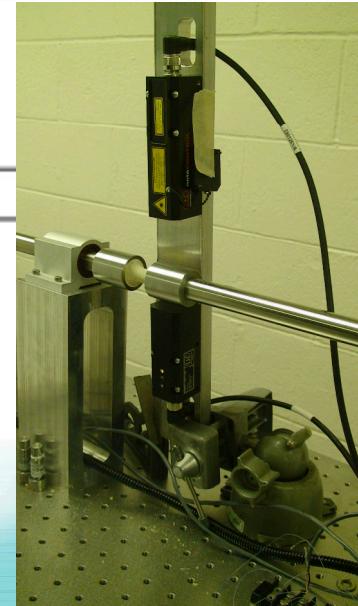
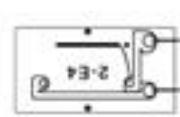
■ Synchronization of stress and strain histories

- Determination of the time for the stress wave propagating in the specimen
 - Longitudinal stress wave in the specimen material

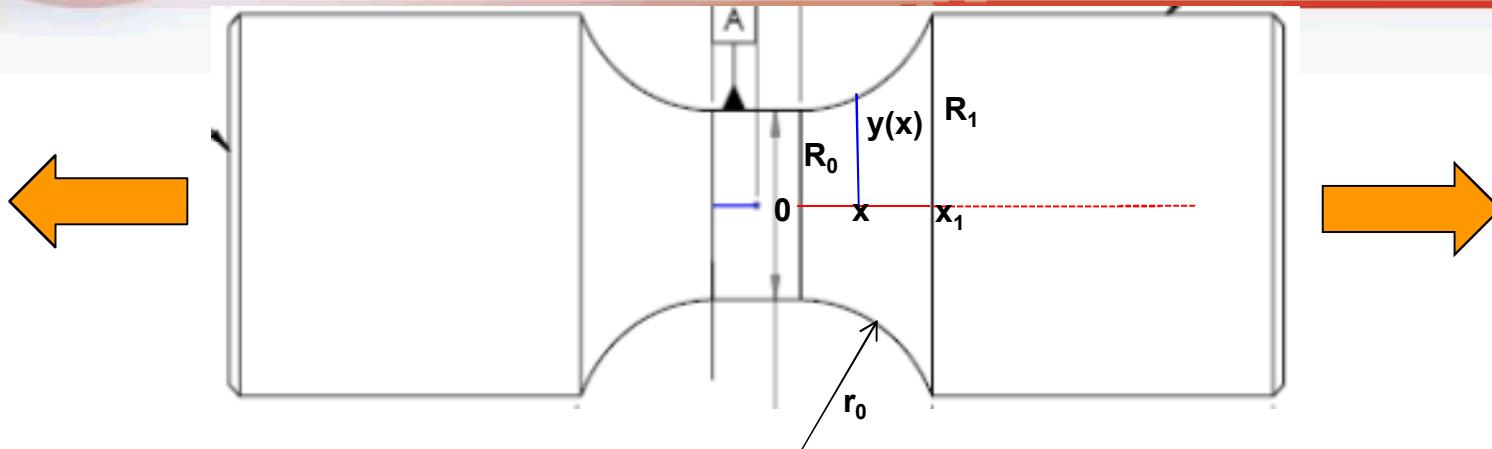


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- Semiconductor strain gages
 - Specimen stress measurement
 - 70 times more sensitive in comparison to regular resistor strain gages
- High-frequency-response laser beam system
 - Micro-epsilon OptiControl Laser Beam System
 - 100 kHz frequency response
 - High resolution: 100 μm
 - Direct displacement measurement of the incident bar end
- High-speed digital image correlation (DIC)



Displacement Correction



Radius

$$y(x) = R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right)$$
$$y(x=0) = R_0$$
$$y(x=x_1) = R_1$$

Area

$$A(x) = \pi \cdot y^2(x) = \pi \cdot \left[R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right) \right]^2$$

Strain

$$\varepsilon(x) = \frac{\sigma(x)}{E} = \frac{F}{E\pi \cdot \left[R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right) \right]^2}$$

Stress

$$\sigma(x) = \frac{F}{A(x)} = \frac{F}{\pi \cdot \left[R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right) \right]^2}$$



Displacement

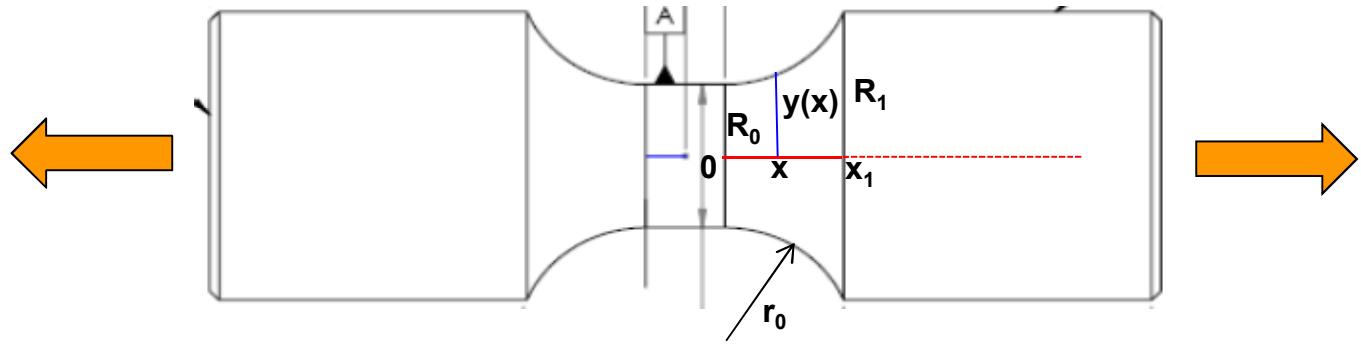
$$dl = \varepsilon(x)dx = \frac{Fdx}{E\pi \cdot \left[R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right) \right]^2}$$



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Displacement Correction

$$\begin{aligned}R_0 &= 0.25 \\r_0 &= 0.406 \\L_s &= 0.25 \\x_1 &= 0.375 \\R_1 &= 0.5\end{aligned}$$



Total Displacement (non-gage section)

$$2l = \frac{2F}{E\pi} \int_0^{x_1} \frac{dx}{\left[R_0 + \left(r_0 - \sqrt{r_0^2 - x^2} \right) \right]^2} = \frac{2F}{E\pi} \times 4.122$$

Total Displacement (gage section)

$$l_g = \varepsilon_g L_s = \frac{F}{E\pi} \cdot \frac{L_s}{R_0^2} = \frac{4F}{E\pi}$$

Correction Coefficient

$$c' = \frac{l_g}{L} = \frac{l_g}{l_g + 2l} = \frac{1}{1 + \frac{2l}{l_g}} = 0.3267$$

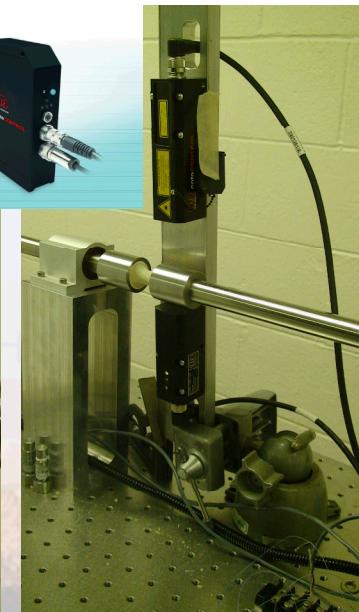
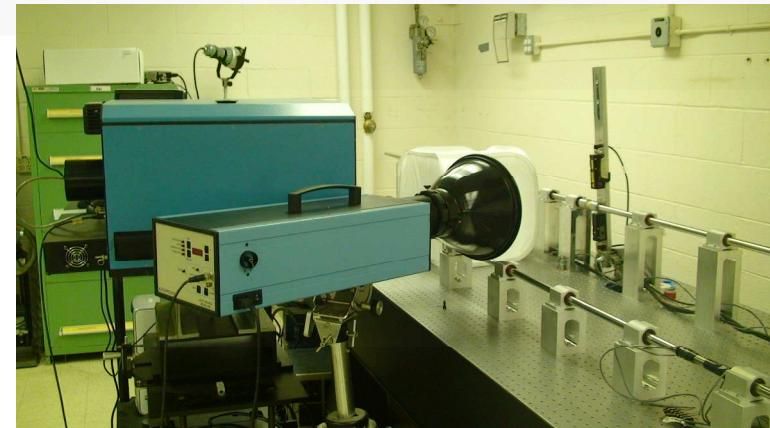
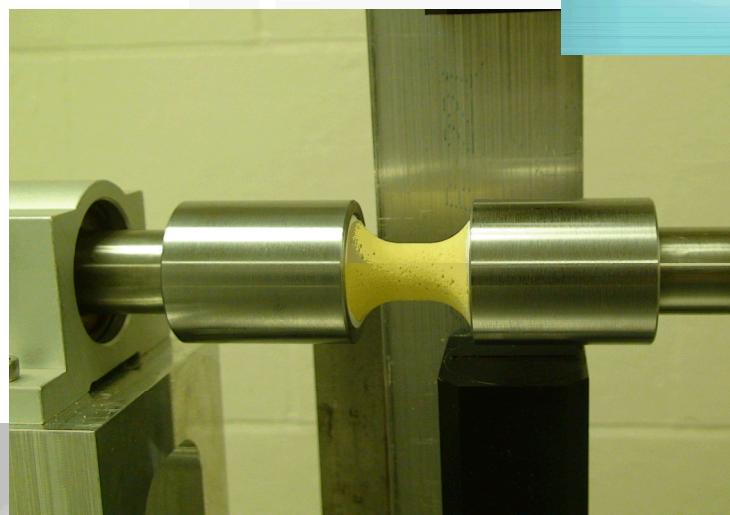
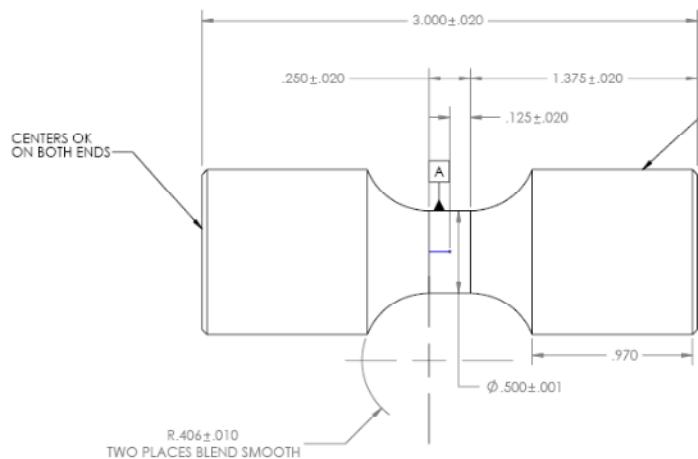
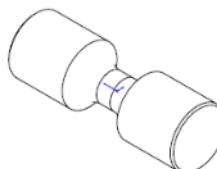


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Example: Dynamic Tensile Characterization of PMDI Foam

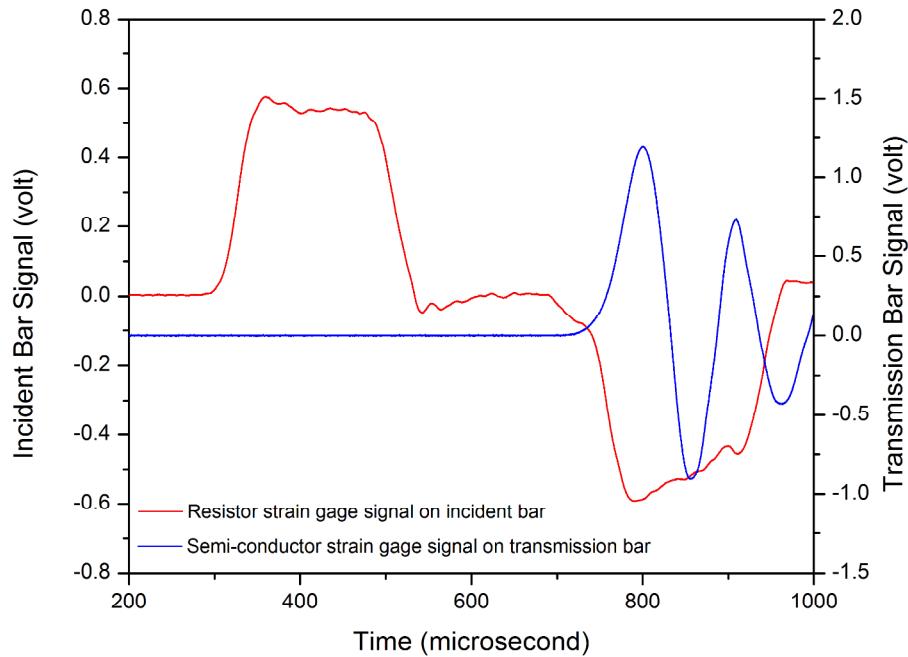
■ Material and specimens

- Polymethylene diisocyanate (PMDI) foam: 16PCF
- Specimens

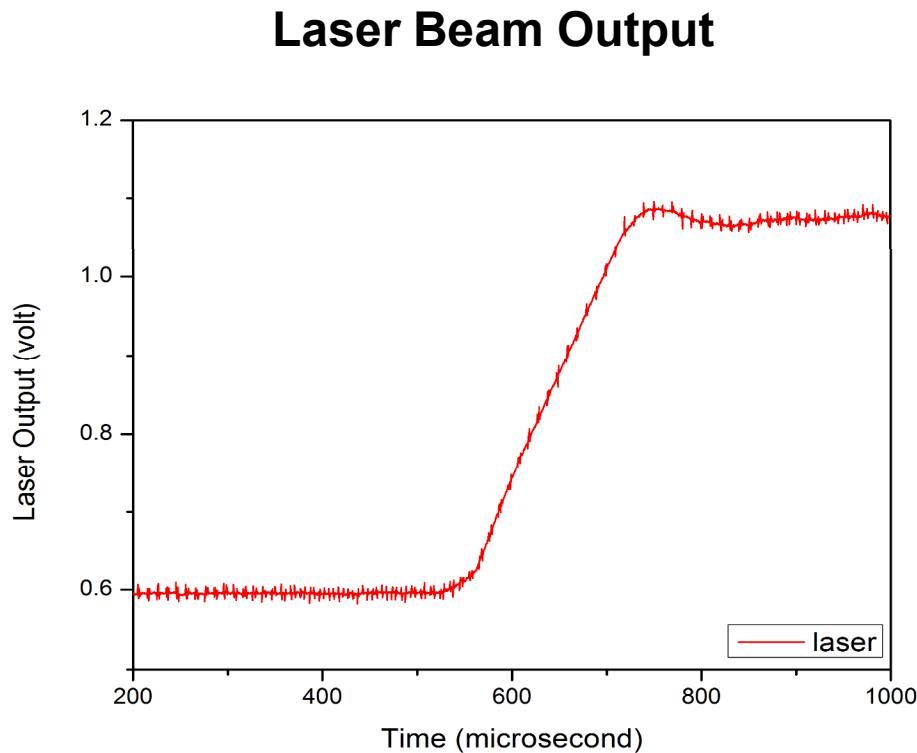


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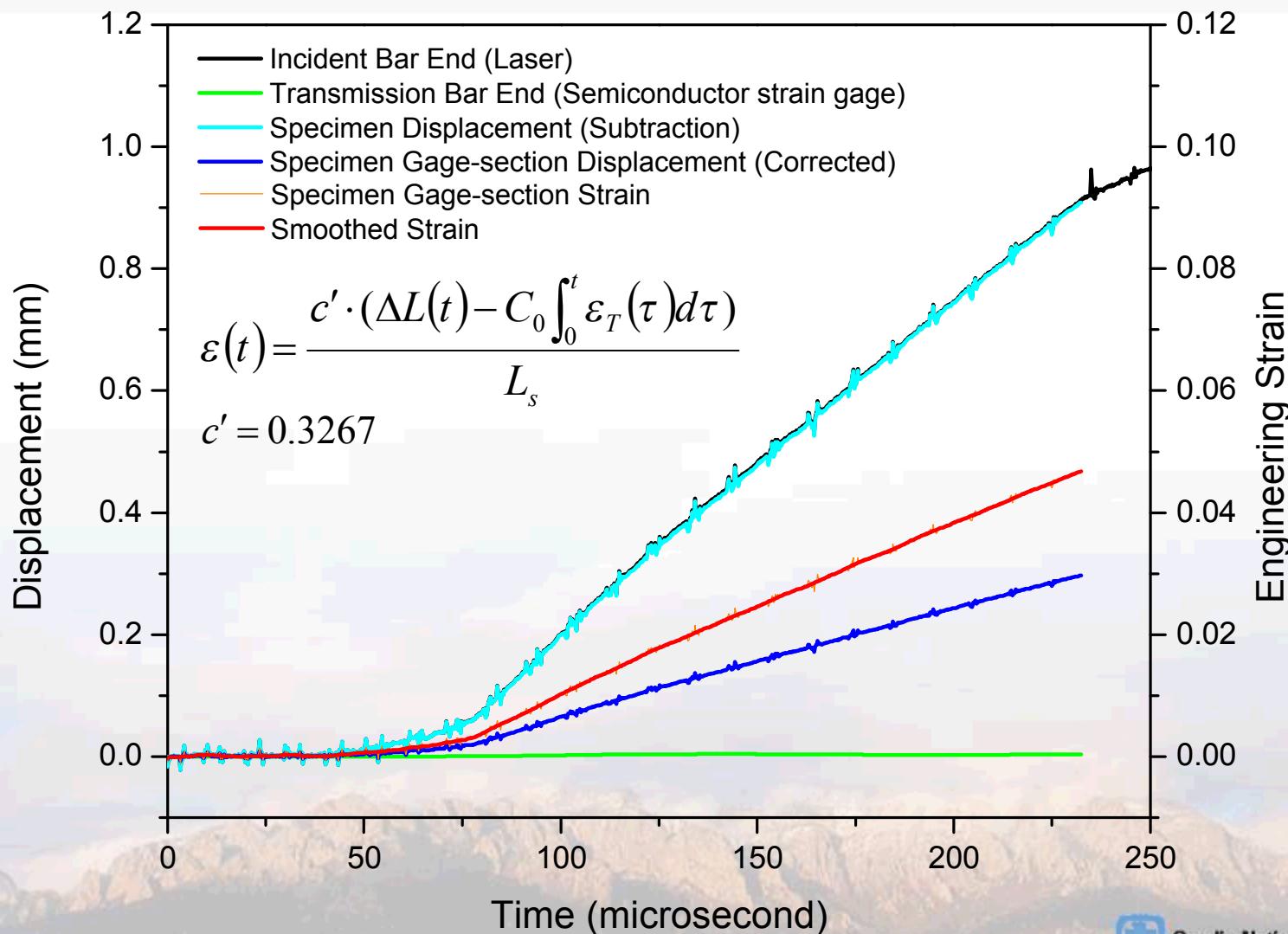
Oscilloscope Records



Bar-strain-gage Output



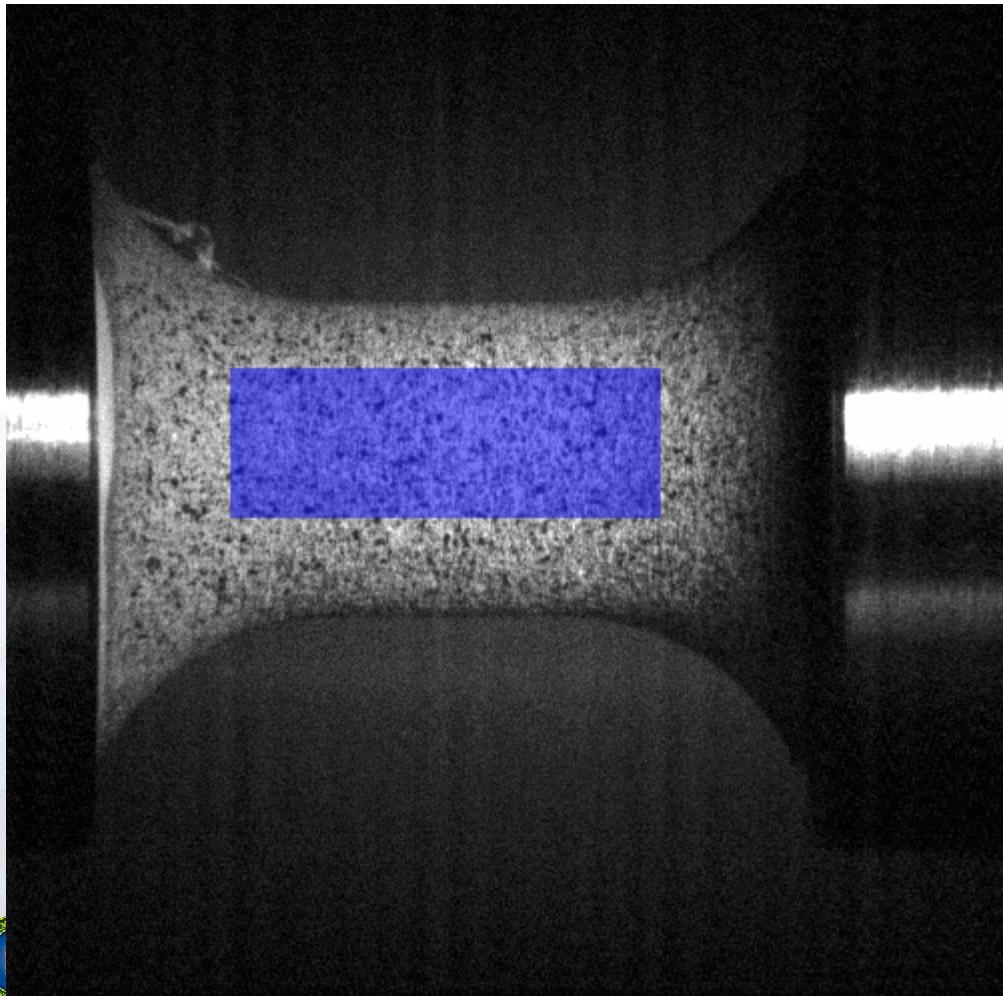
Displacement and Strain Histories



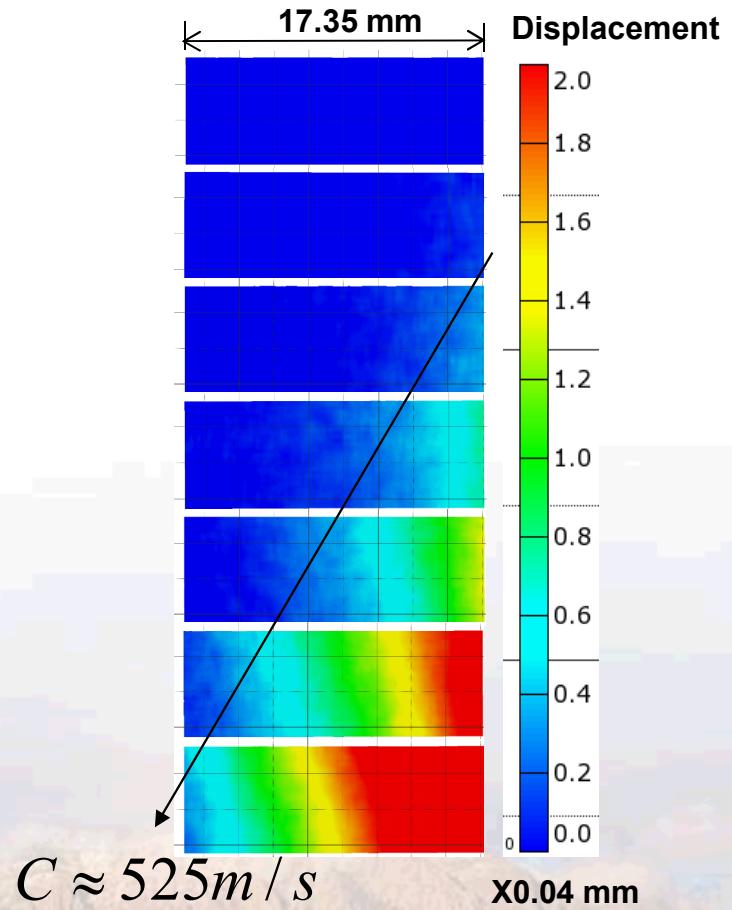
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Longitudinal Wave Speed in Foam Specimen

High-rate Digital Image Correlation (DIC)



0.375" gage length
(3.125" total length)

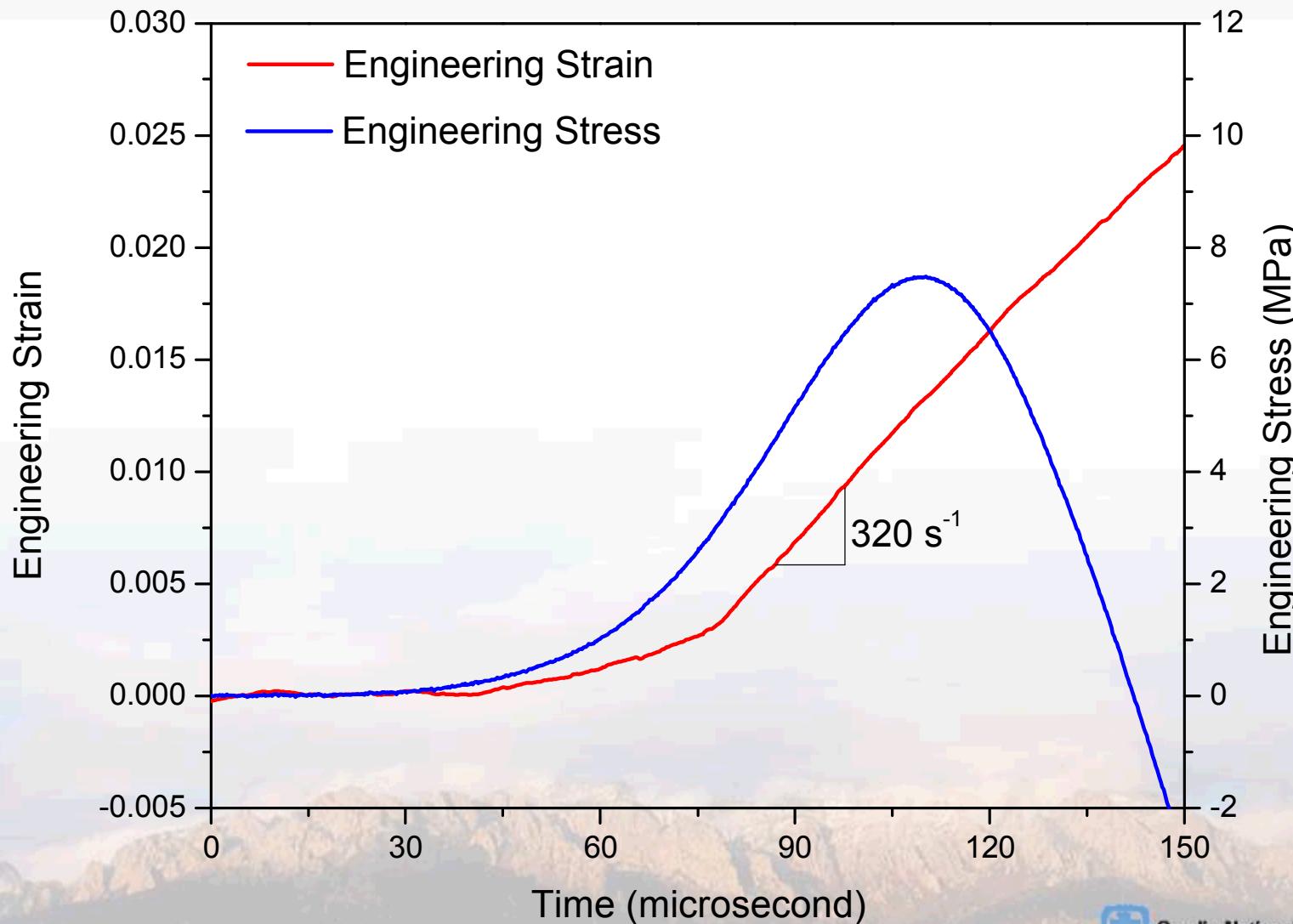


Time interval: 6.6 microsecond



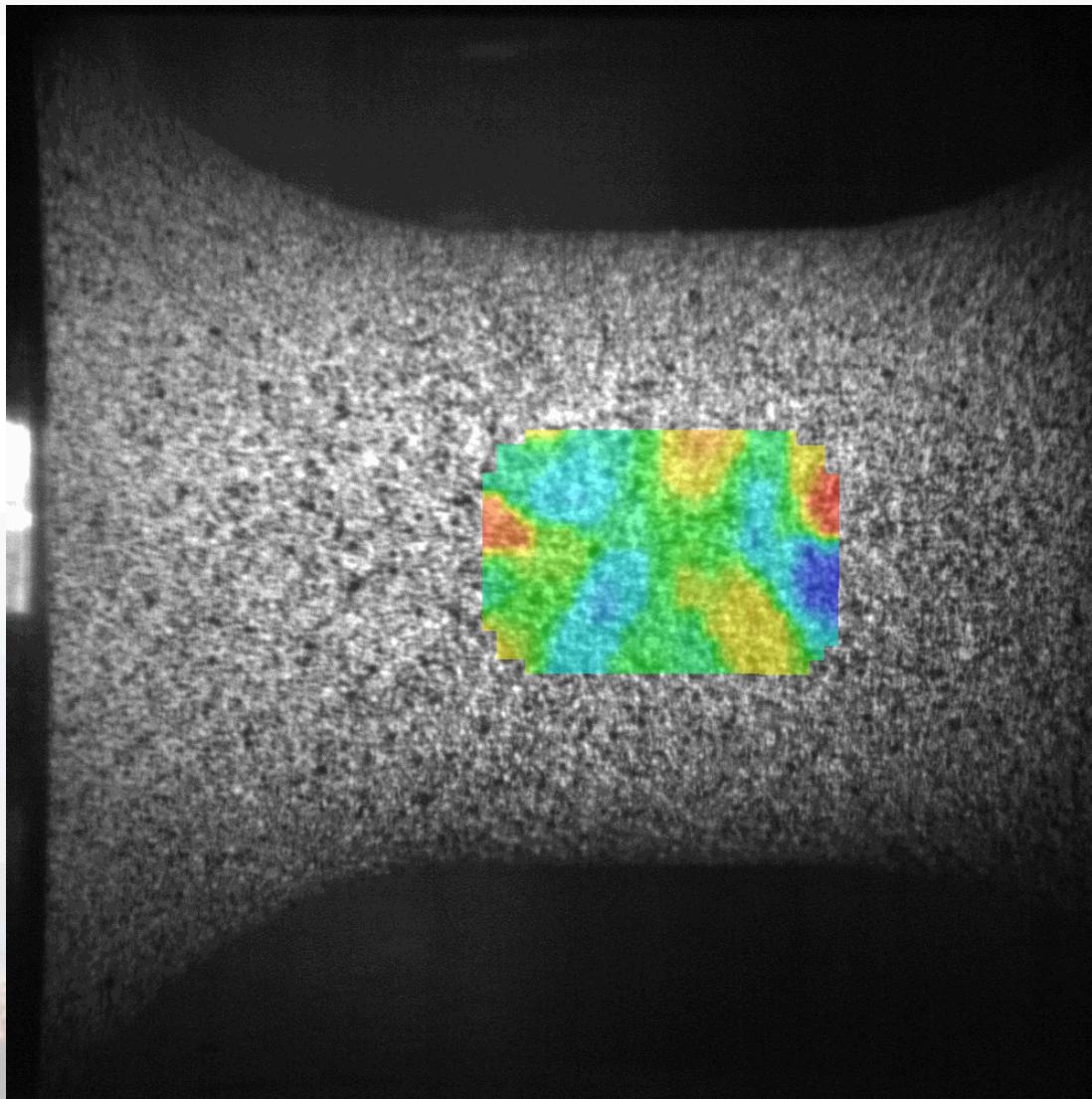
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Synchronized Stress and Strain Histories



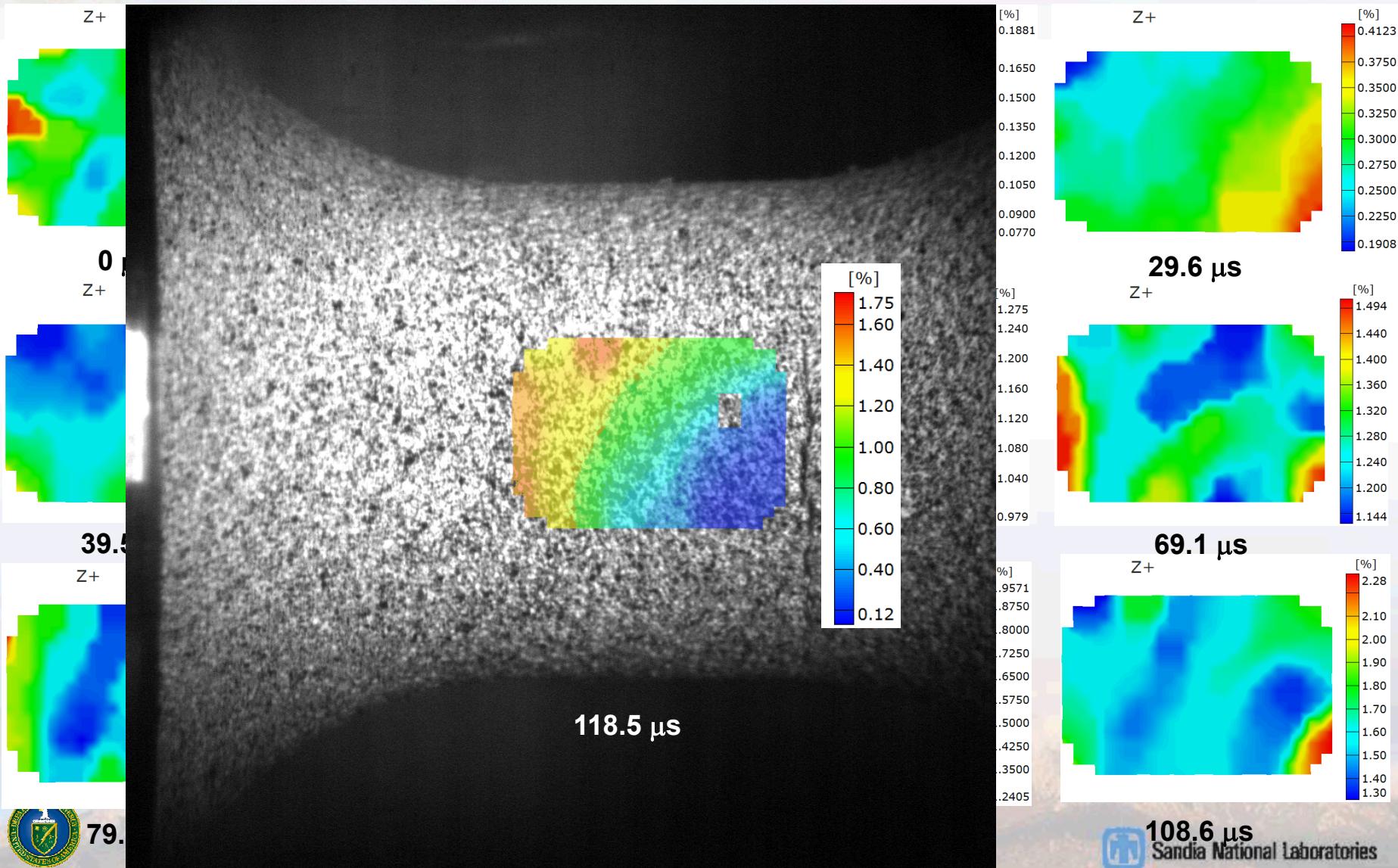
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Uniform Deformation



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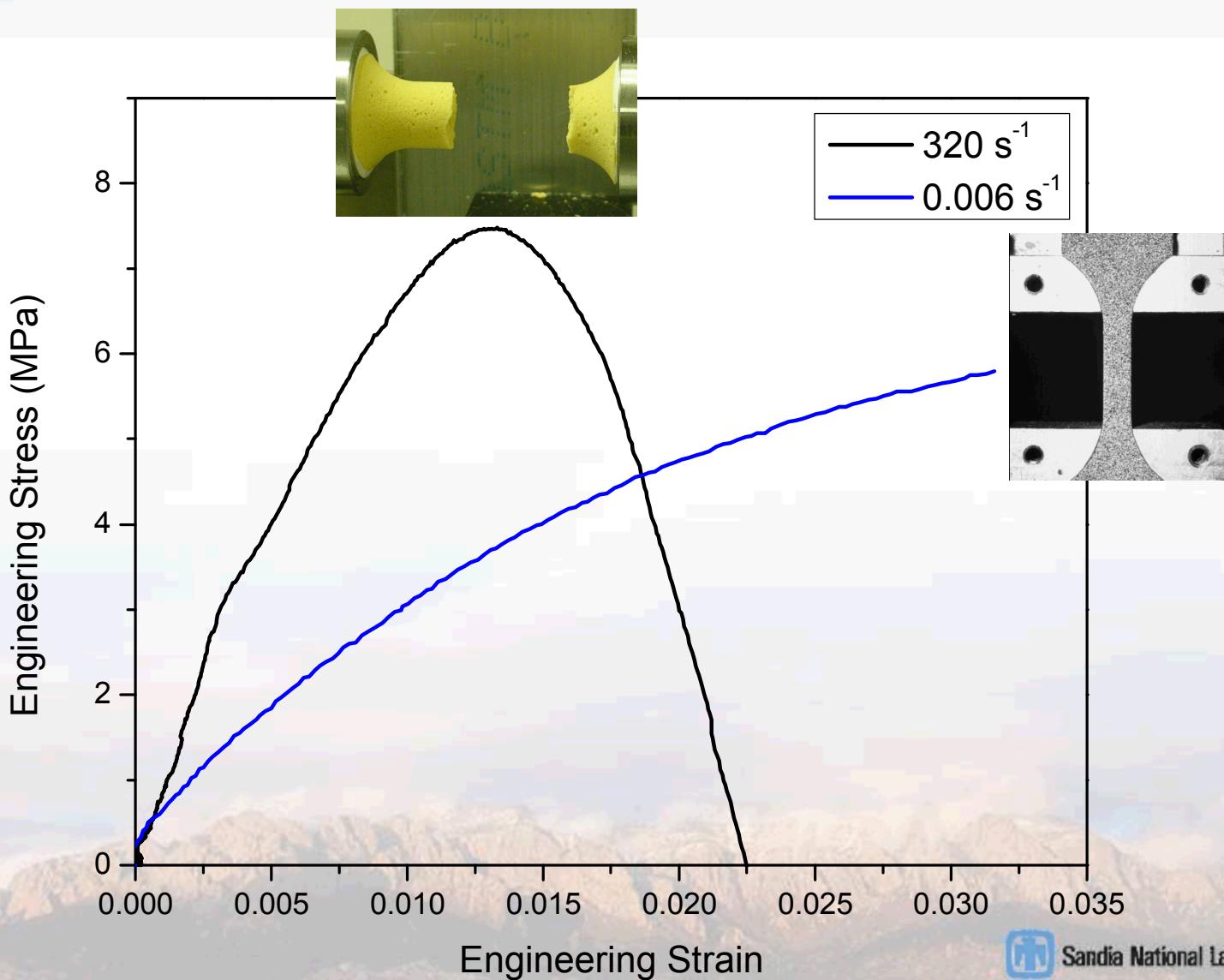
Uniform Deformation



79.

108.6 μ s
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Stress-Strain Curve



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Summary

- High-rate tensile experimental procedure with the Kolsky tension bar has been developed for characterization of foam materials
 - Stress measurement: semiconductor strain gages
 - Strain measurement:
 - Laser beam measurement
 - Specimen gage length correction
 - Stress/strain synchronization:
 - Determination of longitudinal wave speed in foam material (high rate DIC)
 - Validation and verification of testing conditions (stress equilibrium/uniform deformation)
 - Pulse shaping technique
 - Short specimen gage length
 - High-rate digital image correlation



As an example, dynamic tensile stress-strain curve of PMDI foam (16PCF) was obtained at 320 s^{-1}



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